

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

CB TEST CERTIFICATE

Product

Electronic control gear for fluorescent lamps

Name and address of the applicant

HEP Tech Co. Ltd. 20 Jingke 7th Rd. Nantun Dist Taichung 408 Taiwan

Name and address of the manufacturer

HEP GmbH Ramsloh 10

58579 Schalksmuehle

Germany

Name and address of the factory

X Additional information on page 2

HEP GmbH Note: When more than one factory, please report on page 2

Ramsloh 10

58579 Schalksmuehle

Germany

Ratings and principal characteristics Un= 100-277 V; fn= 0/50-60 Hz; PF= 0,95; ta= -25°C - +60°C;

> max. enclosure temperature under abnormal or fault conditions 110 °C (further details see General product information of test report 3409884.50)

Trademark (if any)

HEP Group

Customer's Testing Facility (CTF) Stage used

CTF Stage 2

Model / Type Ref.

SIS118-36I UNI

Additional information (if necessary may also be reported on page 2)

Additional information on page 2

A sample of the product was tested and found

IEC 61347-1:2015, IEC 61347-1:2015/AMD1:2017, IEC 61347-2-3:2011, IEC 61347-2-3:2011/AMD1:2016

to be in conformity with

National differences: **EU Group Differences**

As shown in the Test Report Ref. No. which

3409884.50

forms part of this Certificate

This CB Test Certificate is issued by the National Certification Body

DEKRA Certification B.V. Meander 1051, NL-6825 MJ Arnhem, Netherlands

Date: 2019-01-25



Signature: Susan Lehner



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Additional factory

Weisen Electronic Co. Ltd. Sanzao Ind. Park of Zhuhai, Zhuhai City **Guangdong Province** China

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